


<b>Search Notes</b>  	<b>Application/Control No.</b>  10569787	<b>Applicant(s)/Patent Under Reexamination</b>  HANAMURA ET AL.
	<b>Examiner</b>  Christopher P Schwartz	<b>Art Unit</b>  3683

SEARCHED			
Class	Subclass	Date	Examiner
267	154, 188,273	3/11/08	cps
72	128		

SEARCH NOTES		
Search Notes	Date	Examiner
east		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner